

# Common Quality Anti-Sulfurized Chip Resistor (AEC-Q200)

# Performance Specification

**Test Methods Determine Specifiction** Test Item

Measure between: -55 °C~+125 °C Temperature Coefficient  $0.1\Omega \sim 0.99\Omega$ ±800PPM/°C  $1\Omega \sim 10\Omega$ ±400PPM/°C

±200PPM/°C  $10.1\Omega \sim 100\Omega$ >100Ω ±100PPM/°C

Short Time Overload 2.5 x rated voltage or Max. Overtoad Voltage  $\pm 1\%$ :  $\pm (1.0\% + 0.1\Omega)$ Max

whichever is lower for 5 seconds, then check  $\pm 5\%$ :  $\pm (2.0\% + 0.1\Omega)$ Max the resistance.

 $\pm$ (1.0% + 0.05Ω)Max **Terminal Bending** Duration: 60s ± 5s, then check the resistance. 245±3 °C, 2~3s Solderability 95% coverage Min

 $260 \pm 5$  °C,  $10 \pm 1$ s Soldering Heat  $\pm$ (1.0% + 0.05Ω)Max

Moisture Resistance  $25 \,{}^{\circ}\text{C} \sim 65 \,{}^{\circ}\text{C}, 90 \sim 100\%\text{RH}, 2.5\text{H}, 65 \,{}^{\circ}\text{C}$  $\pm 1\%$ :  $\pm (0.5\% + 0.1 \Omega)$ Max  $90 \sim 100\%$ RH, 3H, 65 °C  $\sim 25$  °C,  $80 \sim 100\%$ RH,  $\pm 5\%$ :  $\pm (3.0\% + 0.1\Omega)$ Max

2.5H. 10 cycles. Measurement at 24 hours after test conclusion.

MIL-STD-202 Method 106

10% rated power, 85 °C/85%RH, 1000H,  $\pm 1\%$ :  $\pm (1.0\% + 0.1 Ω)$ Max **Biased Humidity** Measurement at 24 hours after test conclusion.  $\pm 5\%$ :  $\pm (3.0\% + 0.1\Omega)$ Max

MIL-STD-202 Method 103

Dielectric Withstanding Voltage Resistor shall be clamped in the trough of 90 No evidence of flashover,

metallic V-block and shall be tested at AC potential

respectively specified in the given list of each

product type for 60 ~ 70s.

-55 ± 3 °C 30min ~ normal temperature  $\pm 1\%$ :  $\pm (0.5\% + 0.1 Ω)$ Max **Temperature Cycling**  $\pm 5\%$ :  $\pm (1.0\% + 0.1\Omega)$ Max

10min-15min~155±2 °C 30min~ normaltemperature 10min-15min 100 cycles, Measurement at 24 hours

after test conclusion. JESD22 Method JA-104 125 °C, at 35% rated power.

Load Life  $\pm 1\%$ :  $\pm (1.0\% + 0.1 Ω)$ Max Measurement at 24±2 hours after test conclusion.  $\pm 5\%$ :  $\pm (3.0\% + 0.1\Omega)$ Max

MIL-STD-202 Method 108

 $H_2S 3 \sim 5ppm, 50^{\circ}C \pm 2^{\circ}C, 91\% \sim 93\%RH, 1000H$  $\pm 5\%$ :  $\pm (5.0\% + 0.1\Omega)$ Max Anti-Sulfurized test

 $\pm 1\%$ :  $\pm (1.0\% + 0.1 \Omega)$ Max

mechanical damage, arcing or

insulation breakdown.

## Ordering Procedure: Ex.: CQ06, 1/4W-S, +/-5%,10Ω T/R5000

#### C Q 0 6 S 4 J 0 1 0 0 T 5 Ε

## Resistor Size:

CQ02 = 0402, CQ03 = 0603, CQ05 = 0805, CQ06 = 1206, CQ07 = 1210, CQ10 = 2010,

CQ12 = 2512

Wattage:

Normal size: WH=1/32W, WM=1/20W, WG=1/16W,

WA=1/10W, W8=1/8W, W4=1/4W,

W2=1/2W, 1W=1W

SA=1/10W-S, S8=1/8W-S, S4=1/4W-S, Small size:

S3=1/3W-S, 07=3/4W-S, U2=1/2W-SS

Applicable for Wide Terminal only: WJ=1.5W, 2W, 3W

#### Tolerance:

 $F = \pm 1\%$  $G = \pm 2\%$  $J = \pm 5\%$ 

# Resistance Value:

- E-24 series:
  - 1st digit is "0"

2<sup>nd</sup> & 3<sup>rd</sup> digits are significant figures of the resistance

4th indicates the number of zeros

E-96 series:

1st to 3rd digits are significant figures of the resistance

4th digit indicates the number of

"J" ~0.1, "K" ~ 0.01, "L" ~ 0.001 Jumper: use "0" for 1st to 4th

digits

### Packing Type: T = Tape/Reel

Packing Qty:

1 = 1,000 pcs2 = 2,000 pcs.4 = 4,000 pcs.5 = 5.000 pcs.C = 10,000 pcs.A = 500 pcs.D = 20,000 pcs.E = 15,000 pcs.

## Special Feature:

E = Lead (Pb) Free Plating Type/

RoHS

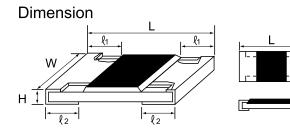
RoHS compliant

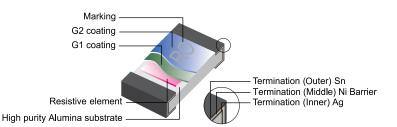
# Common Quality Anti-Sulfurized Chip Resistor (AEC-Q200)

# **Features**

- Small size and light weight
- · Suitable for both wave and reflow soldering
- · Reduction of assembly costs
- Automotive application with Anti Sulfurized Performance
- The relevant provisions of AEC-Q200







Туре	Power Rating at 70°C	Max Working Voltage/Current	Max Overload Voltage/Current	Dielectric Withstanding Voltage	Tolerance %	Resistance Range	Dimension (mm)				
							L	W	Н	l1	l <sub>2</sub>
CQ02 (0402)	1/16W	1A	2A		Jumper	<50m $\Omega$	1.00±0.10	0.50±0.05	0.35±0.05	0.20±0.10	0.25±0.10
		50V	100V	100V	±1% ±2% ±5%	$10\Omega \sim 1M\Omega$ $1\Omega \sim 10M\Omega$ $1\Omega \sim 10M\Omega$					
CQ03 (0603)	1/10W-S 1/16W	1A	2A		Jumper	<50m $\Omega$	1.60±0.10	0.80 <sup>+0.15</sup> -0.10	0.45±0.10	0.30±0.20	0.30±0.20
		50V	100V	100V	±1% ±2% ±5%	$10\Omega \sim 1M\Omega$ $1\Omega \sim 10M\Omega$ $1\Omega \sim 10M\Omega$					
CQ05 (0805)	1/8W-S 1/10W	2A	5A		Jumper	<50mΩ	2.00±0.15	1.25 <sup>+0.15</sup> -0.10	0.55±0.10	0.40±0.20	0.40±0.20
		150V	300V	300V	±1% ±2% ±5%	$10\Omega \sim 1M\Omega$ $1\Omega \sim 10M\Omega$ $1\Omega \sim 10M\Omega$					
CQ06 (1206)	1/4W-S 1/8W	2A	10A		Jumper	<50mΩ	3.10±0.15	+0.15 1.55 -0.10	0.55±0.10	0.45±0.20	0.45±0.20
		200V	400V	400V	±1% ±2% ±5%	$10\Omega \sim 1M\Omega$ $1\Omega \sim 10M\Omega$ $1\Omega \sim 10M\Omega$					
CQ07 (1210)	1/2W-SS 1/3W-S 1/4W	2A	10A		Jumper	<50mΩ	3.10±0.10	2.60±0.20	0.55±0.10	0.50±0.25	0.50±0.20
		200V	500V	500V	±1% ±2% ±5%	$10\Omega \sim 1M\Omega$ $1\Omega \sim 10M\Omega$ $1\Omega \sim 10M\Omega$					
CQ10 (2010)	3/4W-S 1/2W	2A	10A		Jumper	<50m $\Omega$	5.00±0.10	2.50±0.20	0.55±0.10	0.60±0.25	0.50±0.20
		200V	500V	500V	±1% ±2% ±5%	$10\Omega \sim 1M\Omega$ $1\Omega \sim 10M\Omega$ $1\Omega \sim 10M\Omega$					
CQ12 (2512)	1W	2A	10A		Jumper	<50m $\Omega$	6.35±0.10	3.20±0.20	0.55±0.10	0.60±0.25	0.50±0.20
		200V	500V	500V	±1% ±2% ±5%	$\begin{array}{c} 10\Omega {\sim} 1M\Omega \\ 1\Omega {\sim} 10M\Omega \\ 1\Omega {\sim} 10M\Omega \end{array}$					

コエH

#### Note:

- 1.) Metric information inside parenthesis.
- 2.) Standard Operating Temp (°C): -55 ~ +155
- 3.) Standard: E-96 series: 0.5%,1% E-24 series: 2%, 5%
- 4.) Low resistance range  $(0.1\Omega\sim0.99\Omega)$  is also available for CQ02, CQ03, CQ05, CQ06, CQ07, CQ10 and CQ12

# **Derating Curve**

